

# **CISPR TR 16-4-5**

Edition 1.1 2014-07

# CONSOLIDATED VERSION



INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

Specification for radio disturbance and immunity measuring apparatus and methods –

Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods

INTERNATIONAL ELECTROTECHNICAL COMMISSION

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Edition 1.1 2014-07

# **REDLINE VERSION**



### INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

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Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods



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### INTERNATIONAL ELECTROTECHNICAL COMMISSION

# SPECIFICATION FOR RADIO DISTURBANCE AND IMMUNITY MEASURING APPARATUS AND METHODS –

### Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods

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This Consolidated version of CISPR TR 16-4-5 bears the edition number 1.1. It consists of the first edition (2006-10) [documents CISPR/A/665/DTR and CISPR/A/685/RVC] and its amendment 1 (2014-07) [documents CISPR/A/1050/DTR and CISPR/A/1069/RVC]. The technical content is identical to the base edition and its amendment.

In this Redline version, a vertical line in the margin shows where the technical content is modified by amendment 1. Additions and deletions are displayed in red, with deletions being struck through. A separate Final version with all changes accepted is available in this publication.

This publication has been prepared for user convenience.

The main task of IEC technical committees is to prepare International Standards. However, a technical committee may propose the publication of a technical report when it has collected data of a different kind from that which is normally published as an International Standard, for example "state of the art".

CISPR 16-4-5, which is a technical report, has been prepared by CISPR subcommittee A: Radio-interference measurements and statistical methods.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the CISPR 16-4 series, published under the general title Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainties, statistics and limit modelling, can be found on the IEC website.

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# Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods

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#### 2 Normative references

IEC 60050-161:1990, International Electrotechnical Vocabulary (IEV) – Chapter 161: Electromagnetic compatibility

CISPR 16-4-1:2003, Specification for radio disturbance and immunity measuring apparatus and methods – Part 4-1: Uncertainties, statistics and limit modelling – Uncertainty in standardized EMC tests

CISPR 16-4-2:2003, Specification for radio disturbance and immunity measuring apparatus and methods – Part 4-2: Uncertainties, statistics and limit modelling – Uncertainty in EMC measurements



# **CISPR TR 16-4-5**

Edition 1.1 2014-07

# **FINAL VERSION**



### INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

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